

Notice of References Cited	Application/Control No. 10/594,021	Applicant(s)/Patent Under Reexamination PELZER, HEIKO	
	Examiner JENNIFER F. CHANG	Art Unit 2821	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,774,025 A	06-1998	Adam et al.	333/24.1
	B	US-			
	C	US-			
	D	US-			
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	F	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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